



LCLS-II Undulator Segment Measurement Results

HXU-030

LCLS-II HXU Measurement Results

This report is intended to document the results of HXU segment tuning at LBNL and ANL. It should be sent to SLAC for approval before the HXU segment gets shipped.

Serial number from manufacturer's label:

HXU-030

Measurement Procedure:

The measurements have been carried out after the undulator segment had been fully tuned according to "LCLS-II Undulator Test Plan" (LCLS-TN-17-1).

General Hall Probe Scan Evaluation Parameters

Undulator Temperature (should be 20.0)	19.89± 0.02	°C
First core pole # (count includes zero potential pole)	8	
Last core pole # (count includes zero potential pole)	253	
Tuning Gap	9.000	mm

Evaluation of Hall Probe Scans at Commissioning Gap

Commissioning Gap Temperature (should be 20.0)	19.88± 0.05	°C
$\text{rms}(B_{pk} / \langle B_{pk} \rangle - 1)$	0.00170	
K_{eff} at Commissioning Gap (should be 2.3400)	2.3401	
Commissioning Gap	7.927	mm
I1X (over 4.012667 m) (should be within ±40)	-10	μTm
I2X (over 4.012667 m) (should be within ±150)	32	μTm ²
I1Y (over 4.012667 m) (should be within ±40)	-9	μTm
I2Y (over 4.012667 m) (should be within ±150)	-9	μTm ²
Phase Shake (rms phase fluctuations over core poles) (<4.0)	2.25	degXray
Cell Phase Advance (over 4.012667 m)	48,597.9 (135×360-2.06)	degXray
Undulator Entrance Phase ¹	2,248.9 (25×90-1.07)	degXray
Undulator Exit Phase ²	2,249.0 (25×90-0.99)	degXray

¹ Phase advance from cell start (undulator center – 2.006334 m) to center of physical pole 8.

² Phase advance from physical pole 253 to cell end (undulator center + 2.006334 m).



Undulator Encoder Settings

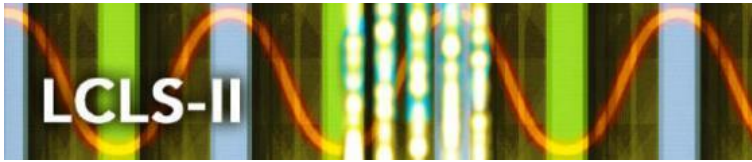
USGapEncoderOffset	NA
DSGapEncoderOffset	NA
USWLinearEncoder.AOFF	90.5556
DSWLinearEncoder.AOFF	90.1819
USALinearEncoder.AOFF	88.9399
DSALinearEncoder.AOFF	91.9226

Undulator Load Cell Readings at Tuning Gap (Gap Opening)

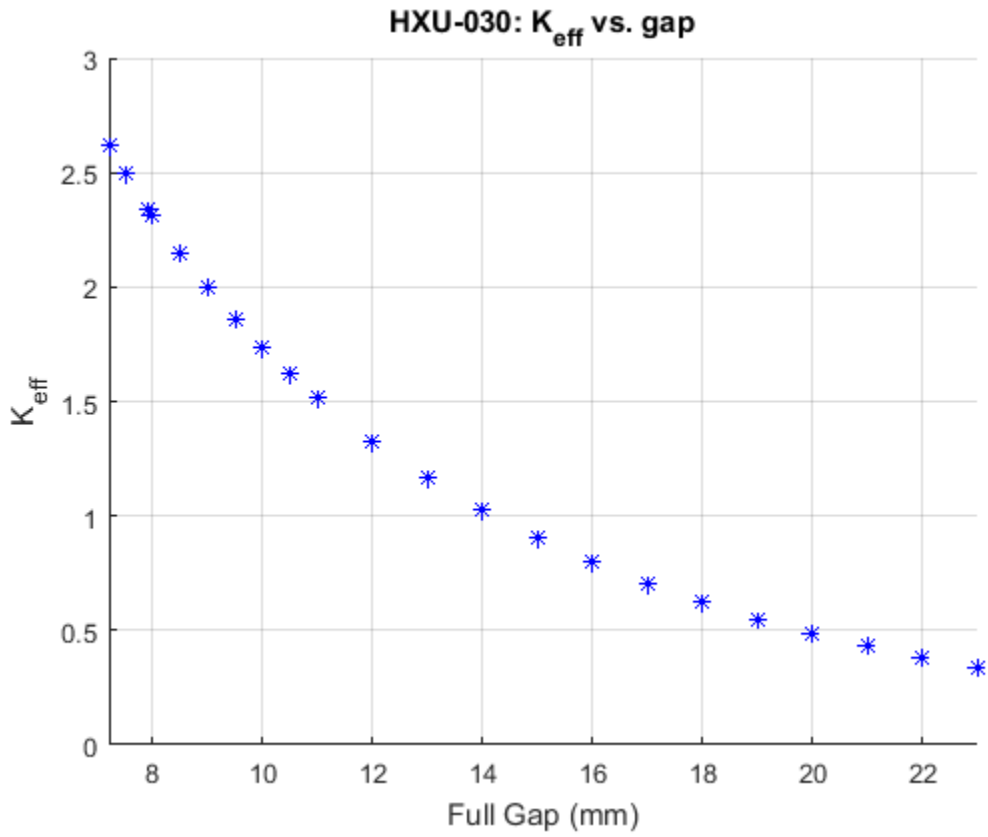
LC_DAL_FORCE	-374.2
LC_DAU_FORCE	-229.6
LC_DWL_FORCE	-237.1
LC_DWU_FORCE	-355.4
LC_UAL_FORCE	-255.2
LC_UAU_FORCE	-350.7
LC_UWL_FORCE	-305.1
LC_UWU_FORCE	-293.4

Undulator Load Cell Readings at 100 mm Gap (Gap Opening)

LC_DAL_FORCE	4.9
LC_DAU_FORCE	3.0
LC_DWL_FORCE	1.1
LC_DWU_FORCE	1.9
LC_UAL_FORCE	3.0
LC_UAU_FORCE	2.1
LC_UWL_FORCE	5.1
LC_UWU_FORCE	4.8

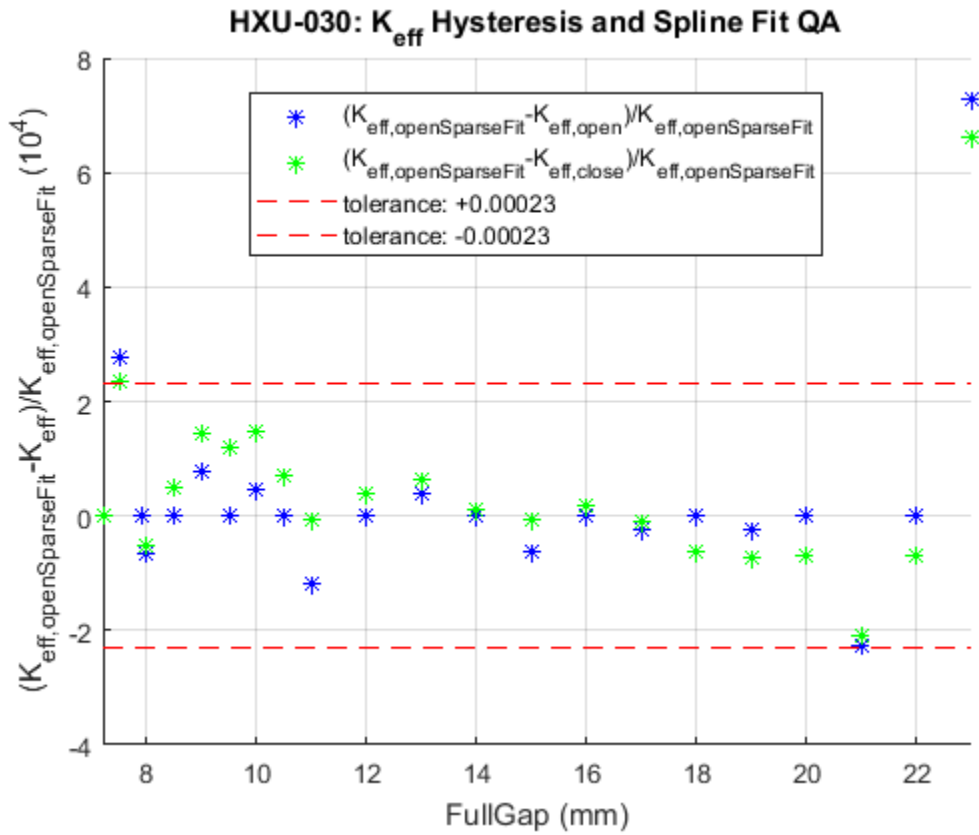


Evaluation of Hall Probe Scans: K_{eff} vs gap





Evaluation of Hall Probe Scans: K_{eff} Hysteresis using Half Gap Encoders

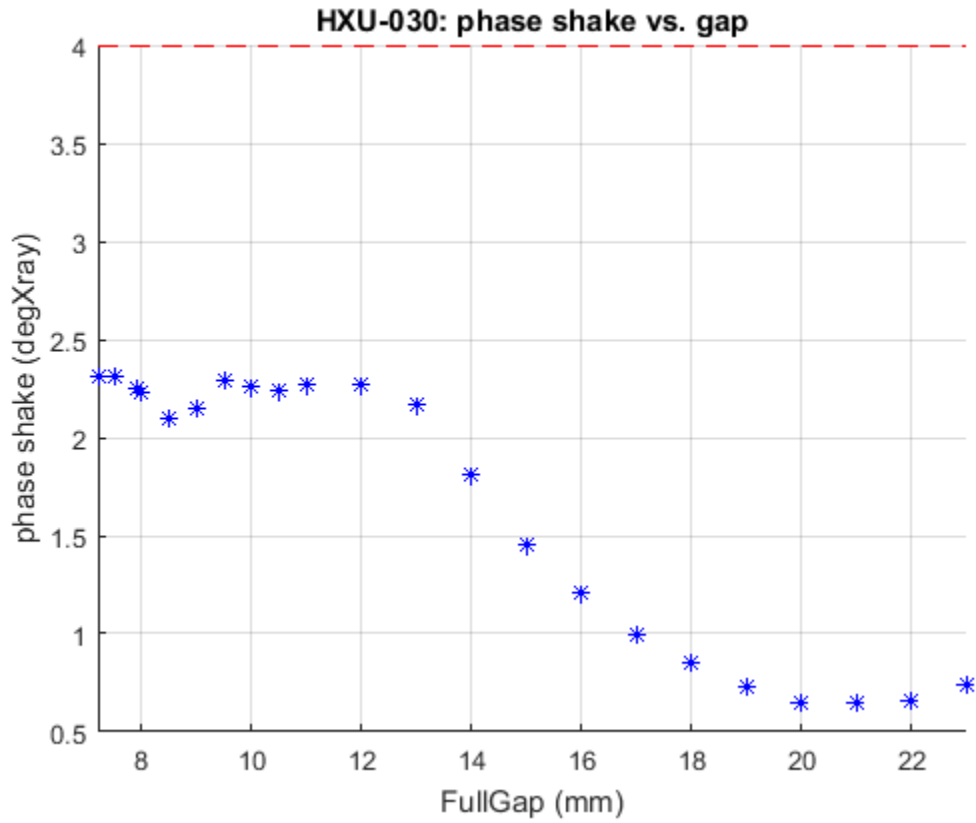


Plotted functions have been calculated from measured values openKeff (opengap) and closeKeff (closegap) using the following Matlab calculations:

Blue Stars: `1-openKeff ./ spline(opengap(1:2:end),openKeff(1:2:end),opengap)`
 Green Stars: `1-closeKeff ./ spline(opengap(1:2:end),openKeff(1:2:end),closegap)`



Evaluation of Hall Probe: Phase Shake vs. gap

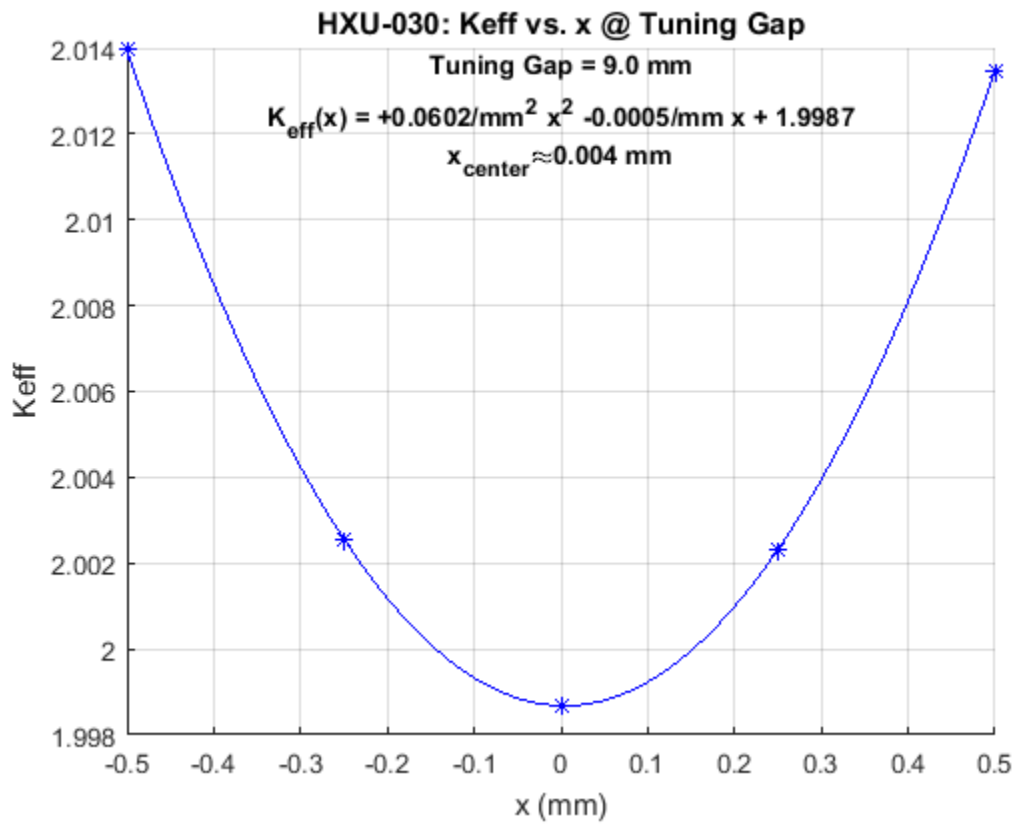




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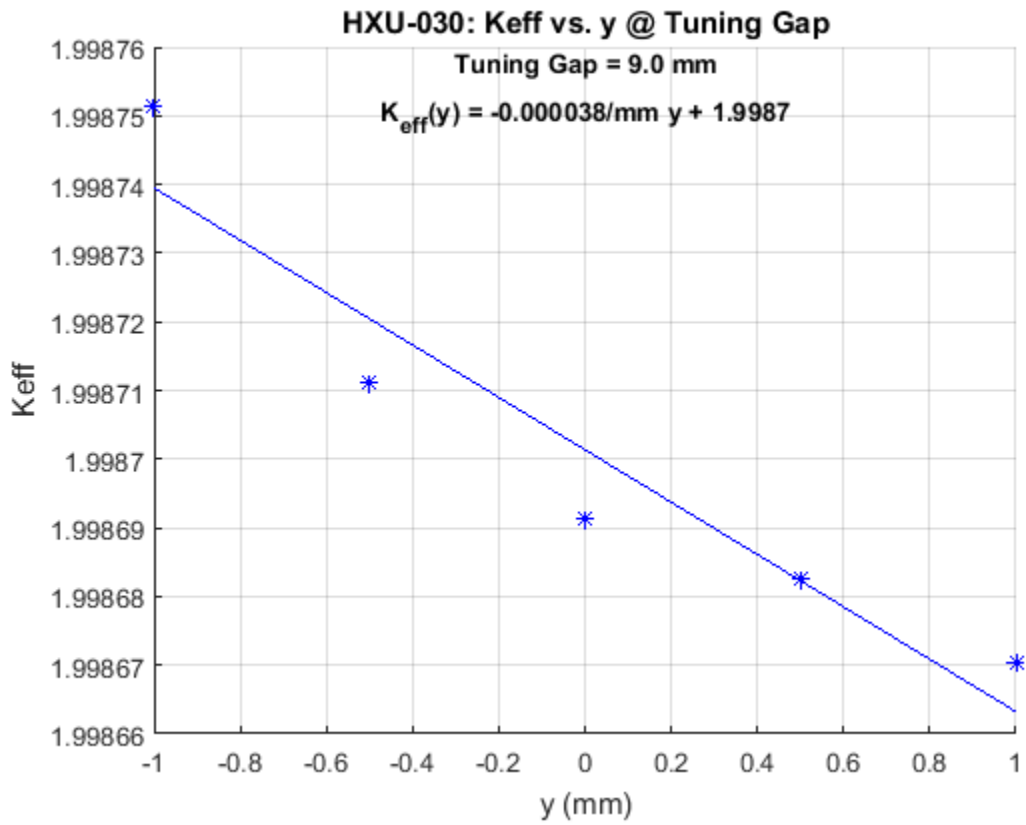
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Evaluation of Hall Probe: K_{eff} vs x at Tuning Gap



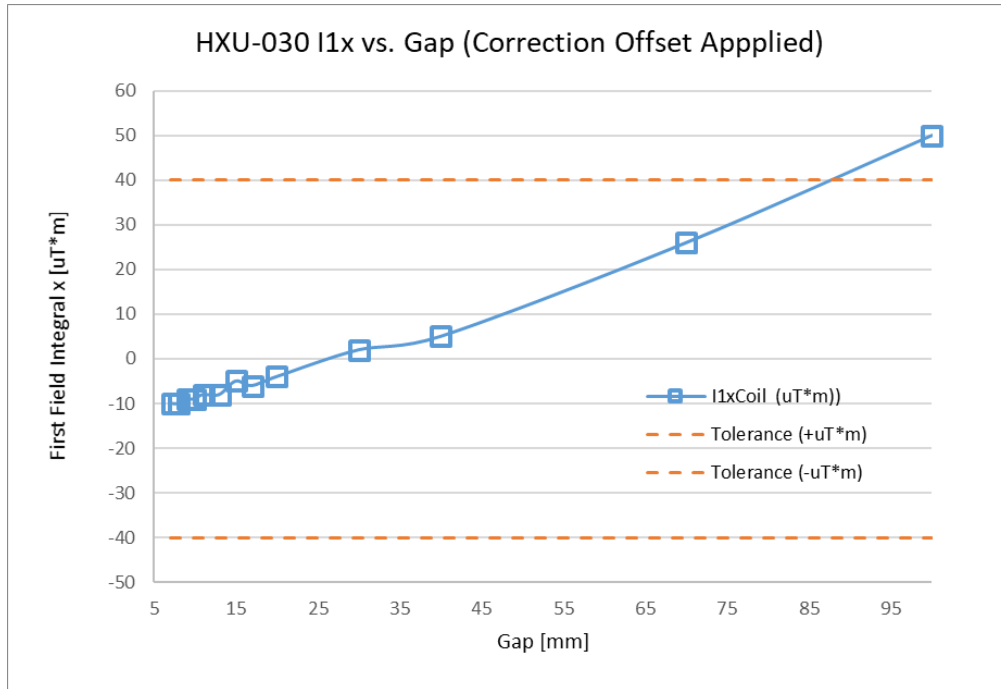


Evaluation of Hall Probe: K_{eff} vs y at Tuning Gap



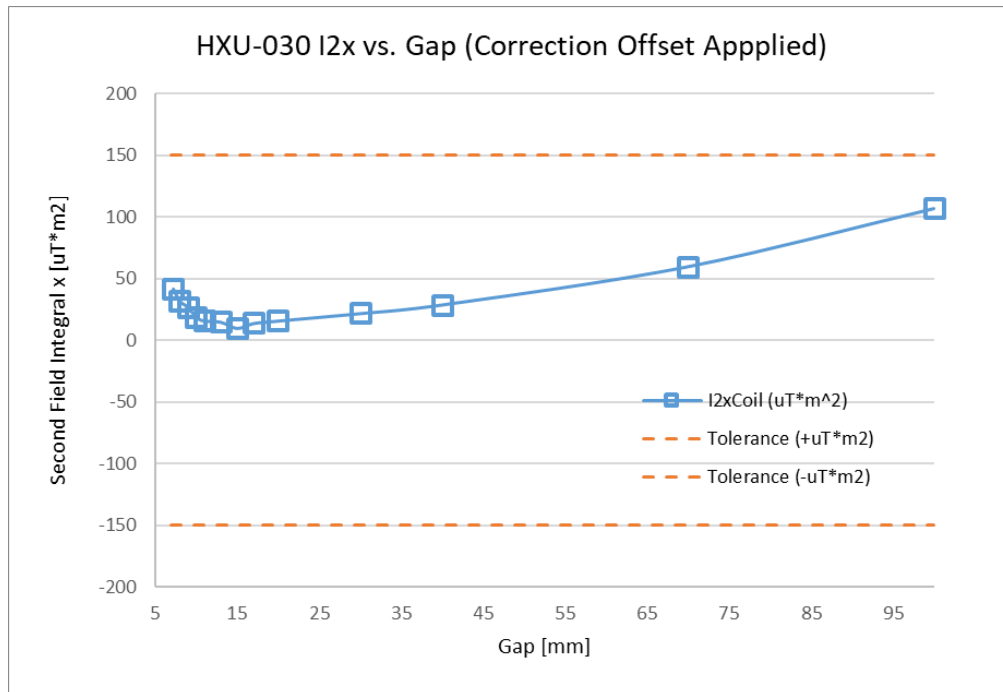


Long Coil Measurement of the On-Axis First Horizontal Field Integrals with +30 $\mu\text{T}\cdot\text{m}$ Integral Offset



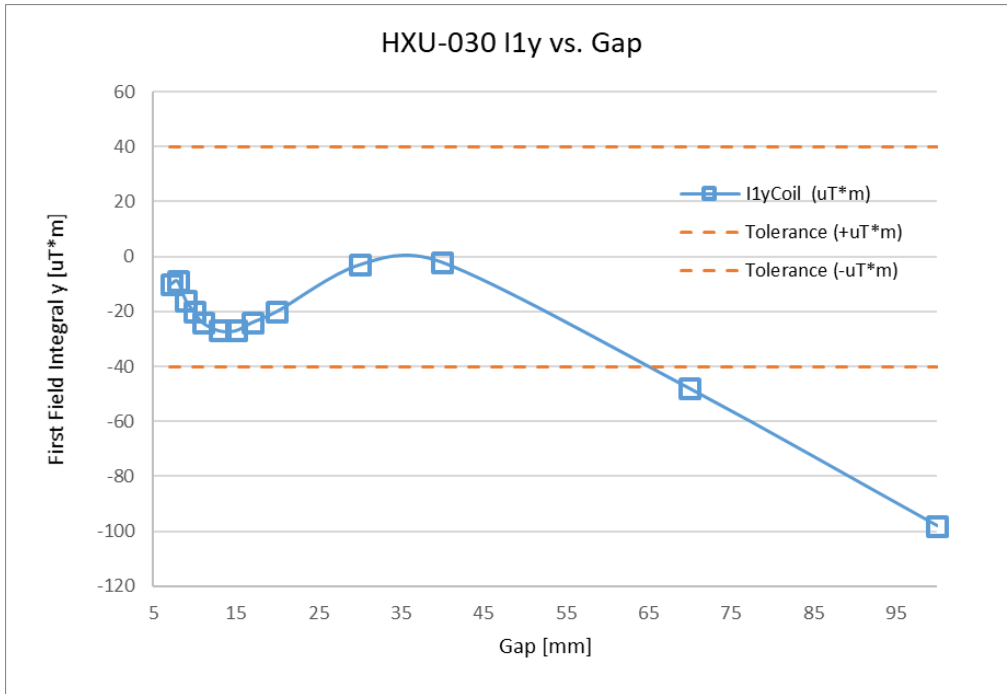


Long Coil Measurement of the On-Axis Second Horizontal Field Integrals with $+30 \mu\text{T}\cdot\text{m} \times 0.5 \times 4.012667 \text{ m}$ Second Integral Offset



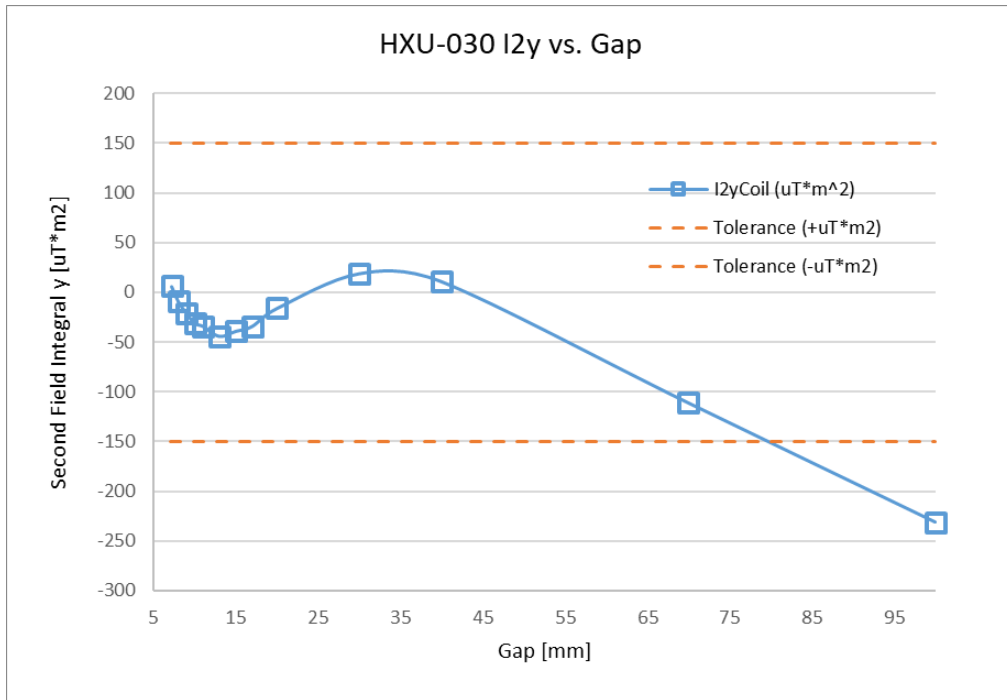


Long Coil Measurement of the On-Axis First Vertical Field Integrals





Long Coil Measurement of the On-Axis Second Vertical Field Integrals

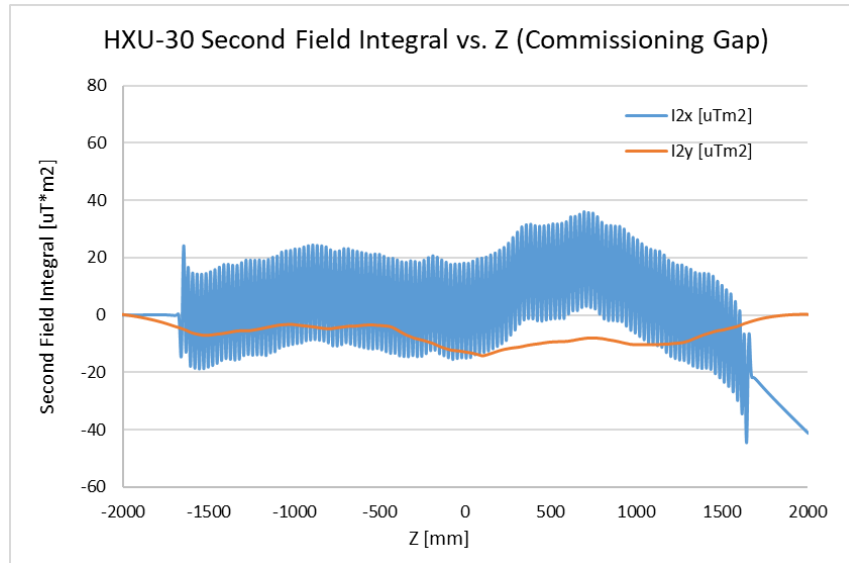


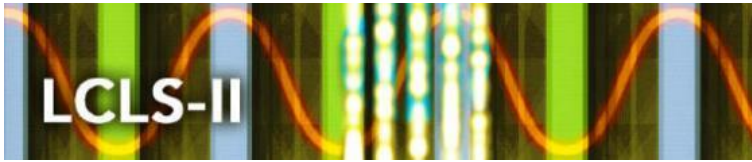


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Second Horizontal and Vertical Field Integrals along Undulator Length at Commissioning Gap

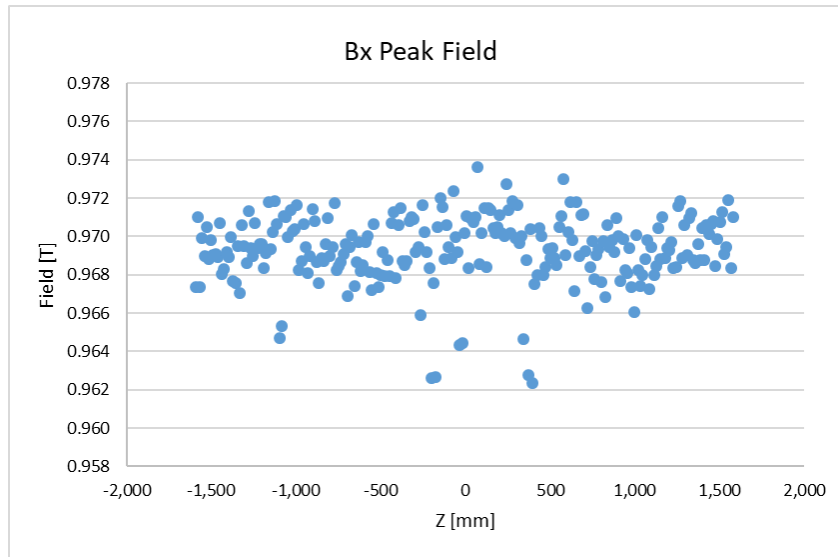




LCLS-II Undulator Segment Measurement Results

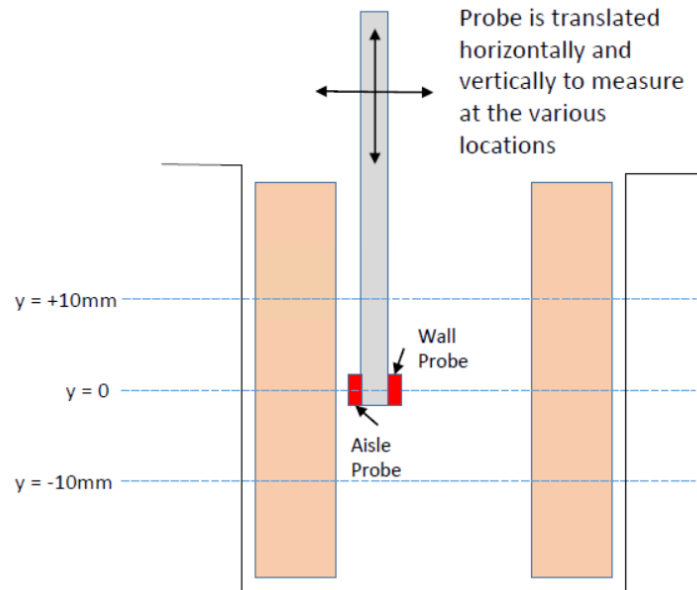
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Horizontal Peak Field along Undulator Length at Commissioning Gap





Capacitive Sensor Arrangement



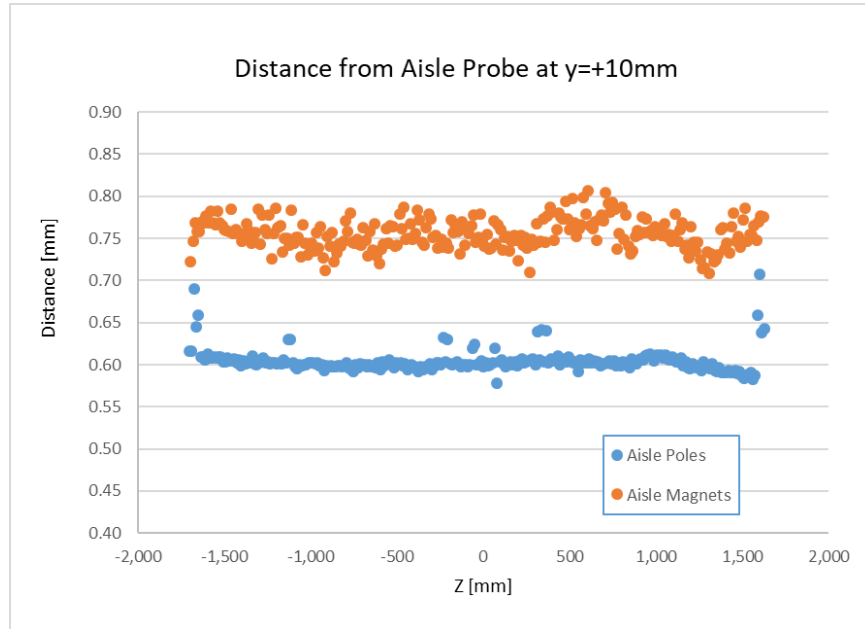
The following plots show the pole and magnet position measurements. The ANL system has two back-to-back capacitive probes on one probe holder. The x and y stages on the 6-meter bench are positioned so that the probe is in the proper location for each of the 9 scan locations. For the data analysis, the average pole position in each scan is used as reference for the plotted pole and magnet positions. Note that for all plots, the first three and last three poles of the device are omitted since the measurement is not accurate due to end effects in the capacitance probe measurement.



LCLS-II Undulator Segment Measurement Results

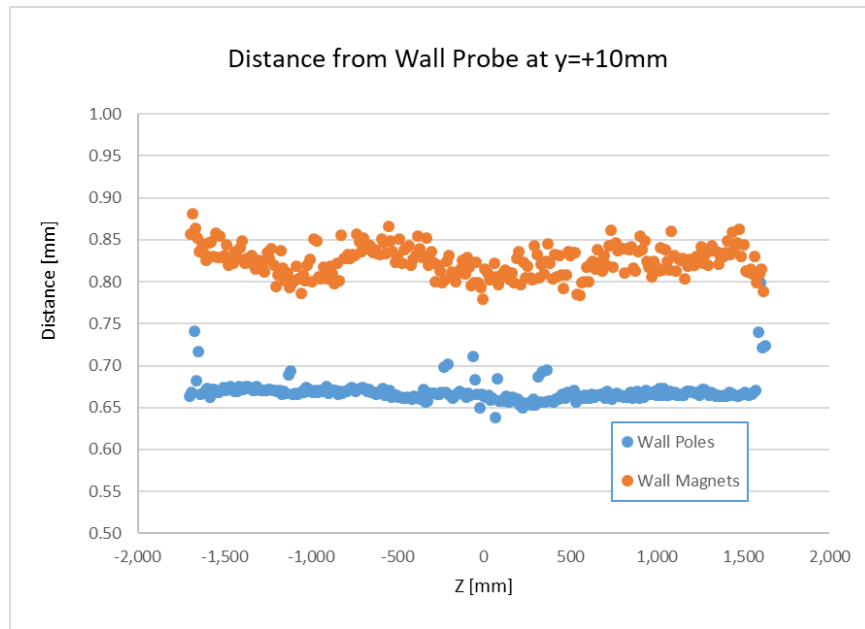
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Aisle Capacitive Sensor Readings $y = +10\text{mm}$





Wall Capacitive Sensor Readings $y = +10\text{mm}$

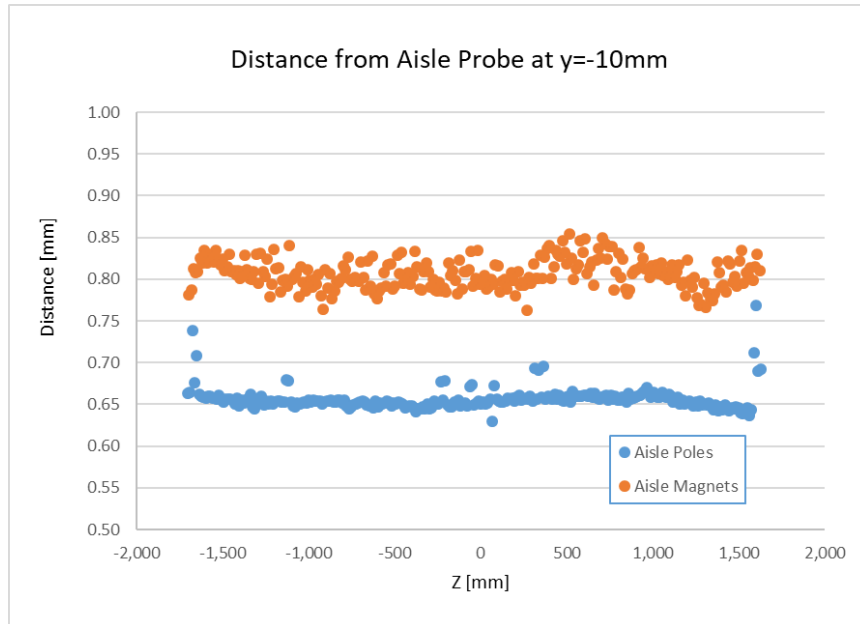


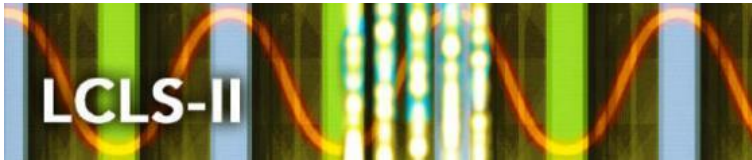


LCLS-II Undulator Segment Measurement Results

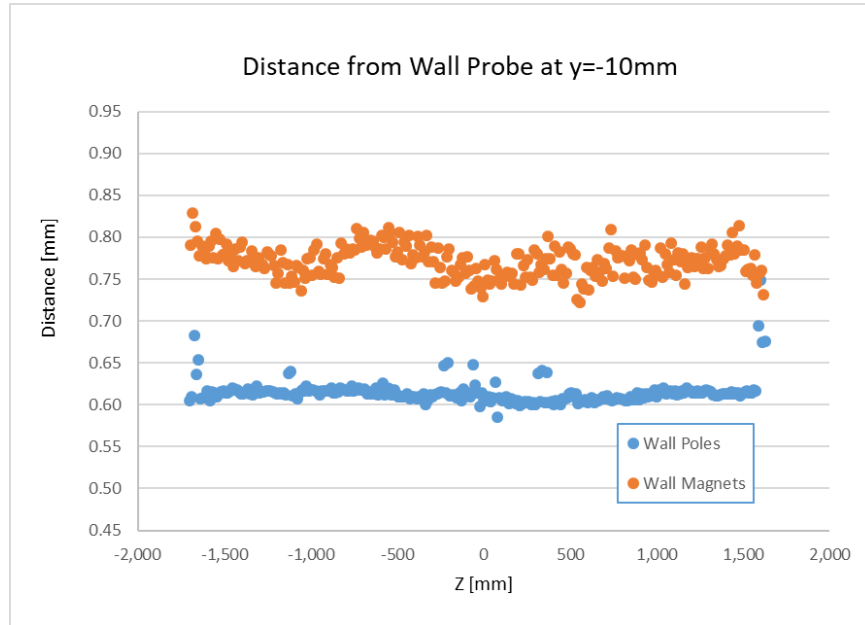
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Aisle Capacitive Sensor Readings $y = -10\text{mm}$



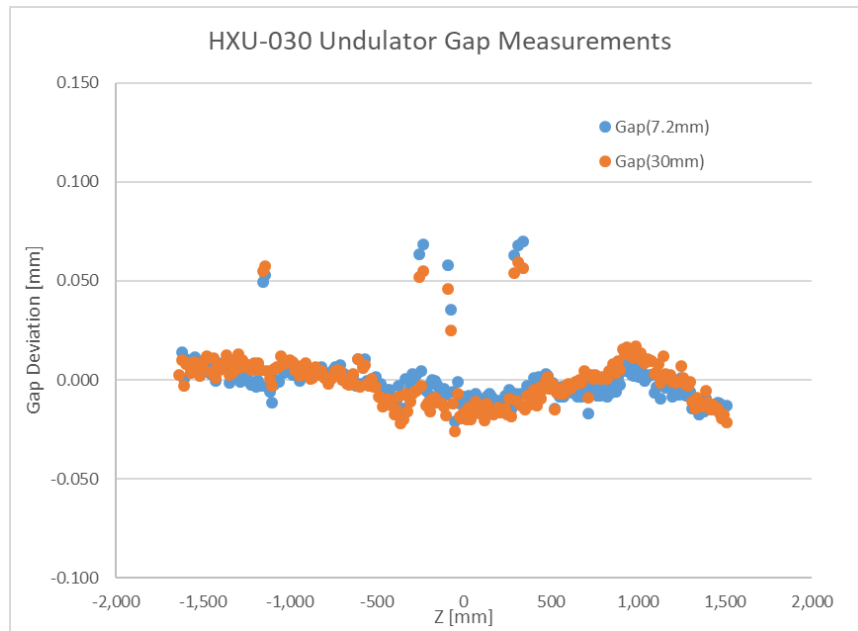


Wall Capacitive Sensor Readings $y = -10\text{mm}$





Undulator Gap Measurements

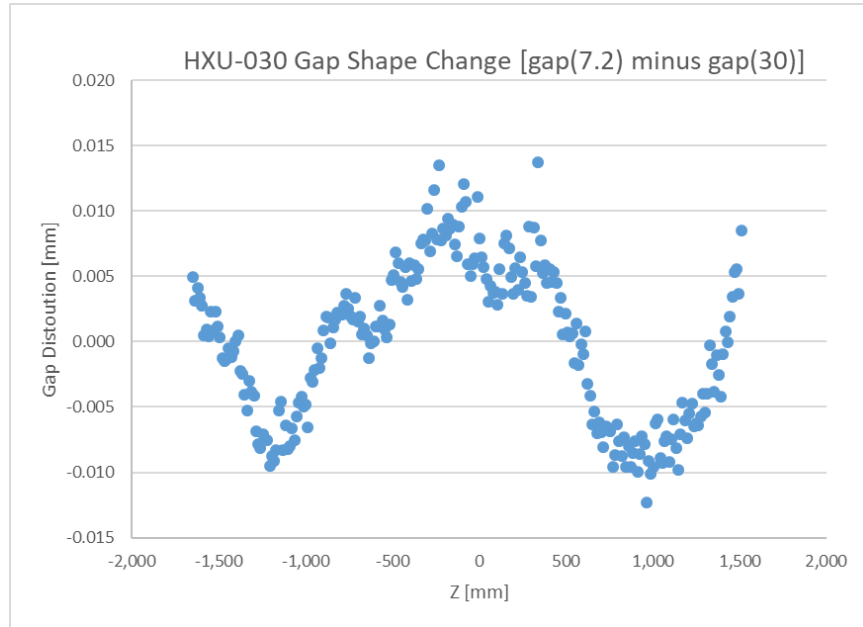




LCLS-II Undulator Segment Measurement Results

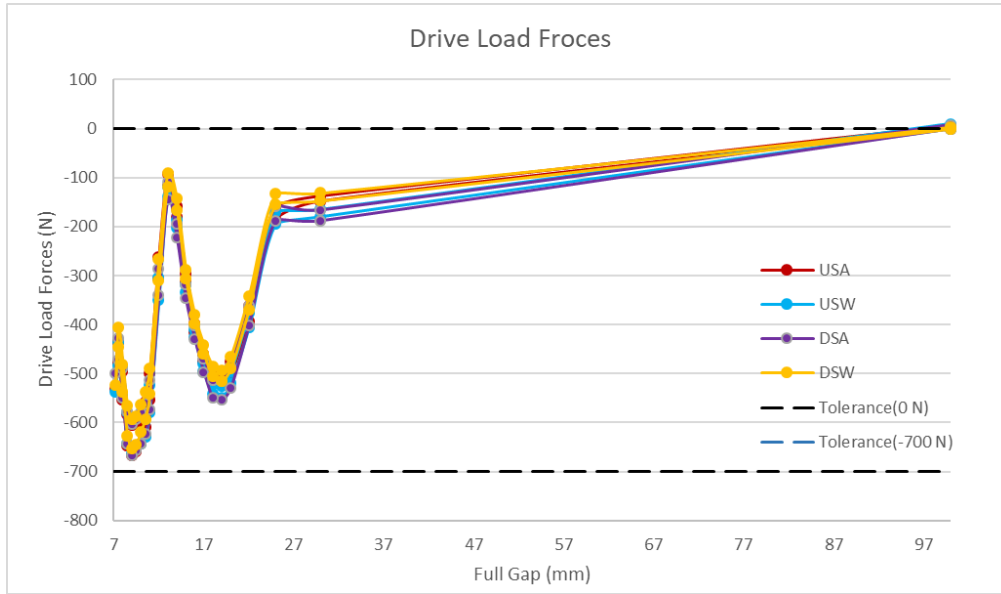
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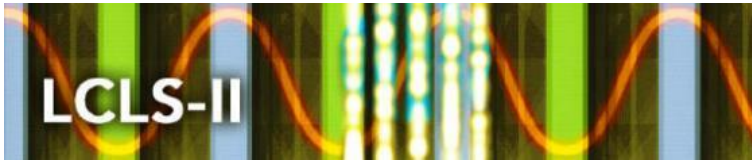
Undulator Gap Difference



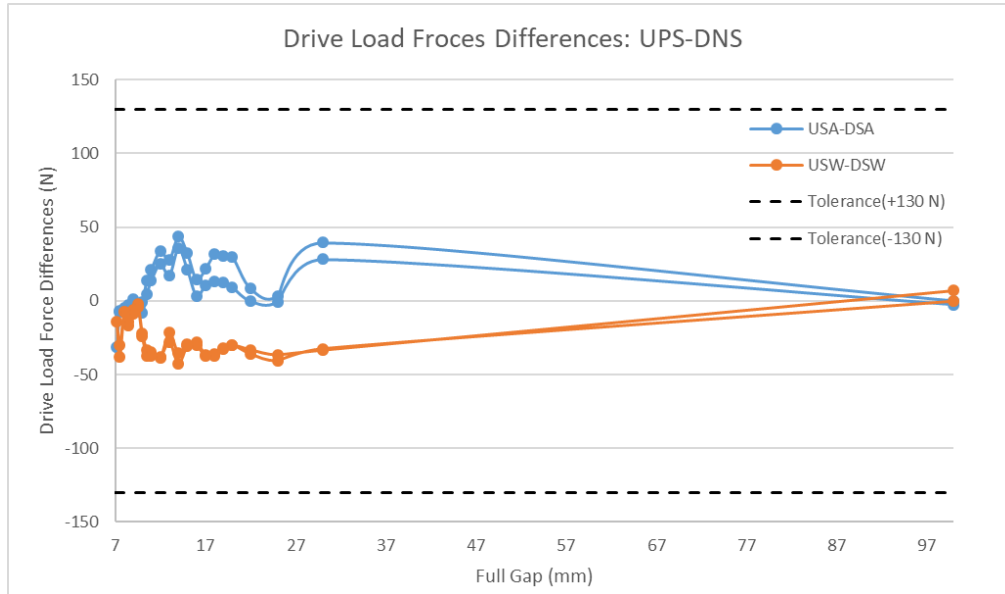


Drive Loads (Gap Opening)



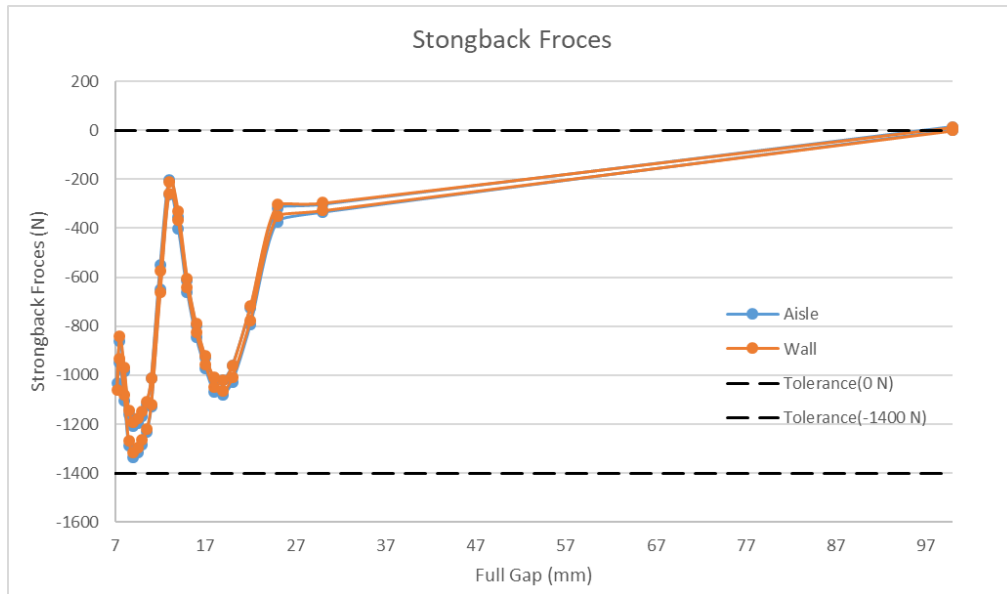


Drive Load Differences (Gap Opening - Closing)





Strongback Forces (Gap Opening and Closing)





Strongback Force Differences (Gap Closing - Opening)

